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#### **Telegraph Frequency Noise in Electromechanical Resonators**

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#### Abstract

We demonstrate experimentally the possibility to reveal fluctuations in the eigenfrequency of a resonator when the frequency noise is of the telegraph type. Using a resonantly driven micromechanical resonator, we show that the time-averaged vibration amplitude spectrum exhibits two peaks. They merge with increasing rate of frequency switching and the spectrum displays an analog of motional narrowing. We also show that the moments of the complex amplitude depend strongly on the frequency noise characteristics. This dependence remains valid even when strong thermal or detector noise is present.

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#### I. INTRODUCTION

The decay and loss of coherence of oscillations is of paramount importance in resonators<sup>1</sup>, from Josephson junctions<sup>2,3</sup> to nano- and opto-mechanical systems<sup>4–7</sup>. In the vast majority of cases where the resonator is coupled to a thermal bath, the decay of vibrations is associated with thermal fluctuations in both the amplitude and the phase of the vibrations. Phase noise is particularly important because it directly determines the sensitivity of these devices to act as resonant detectors<sup>8</sup> and their stability to serve as precision clocks<sup>9</sup>. Apart from originating thermally, phase fluctuations can also arise due to fluctuations in the eigenfrequency of the resonator<sup>10</sup>. In mechanical systems, such frequency noise can be generated by a number of sources, including the coupling of the vibration mode to two-level systems<sup>11,12</sup>, random adsorption and desorption of molecules on the surface of the resonator<sup>13–15</sup>, as well as the diffusion of adsorbed molecules along the resonator<sup>16</sup>.

There has been much interest in identifying frequency noise because study of its statistics allows one to probe the underlying physics of mesoscopic systems<sup>15,17,18</sup>. Frequency noise can be directly measured if the eigenfrequency varies slowly with time and thus can be accurately measured by, for instance, fitting to a resonance peak. Rapid changes of the eigenfrequency (faster than the inverse damping constant) may be detectable by observing the ringdown of oscillations or driving the resonator into self oscillations with a phase locked loop. However, due to the presence of detector noise and/or thermal noise, in practice it is not straightforward to isolate frequency fluctuations from other sources of phase noise.

To characterize phase noise, a common method involves driving the resonator with a sinusoidal excitation at a frequency close to the eigenfrequency and measuring the two oscillation quadratures X and Y that are in phase and out of phase with the drive<sup>9,19,20</sup>. For sufficiently large oscillation amplitudes, the anisotropy of the distribution in the X-Y phase space due to frequency noise can exceed the broadening due to thermal and detector noise. Using this method, the intrinsic frequency fluctuations of a silicon nitride resonator was recently measured<sup>20</sup>. The feasibility of this approach relies on the resonator remaining in the linear regime even in the presence of the strong periodic drive. For resonators with a low threshold of onset of nonlinearity, including graphene and carbon nanotube mechanical resonators<sup>13,21–23</sup>, such scheme may not be applicable. Recently, it is proposed that frequency noise can be identified in the spectra of the higher moments of the complex amplitude<sup>24,25</sup>

of vibrations. Furthermore, the higher moments also provide useful information about noise characteristics.

In the present paper, we perform a comprehensive study of frequency noise of the telegraph type. The experiment is done with a micromechanical torsional resonator. When the resonator is subjected to random telegraph frequency noise (RTFN), its eigenfrequency jumps randomly between two values  $\omega_{1,2} = \omega_0 \pm \Delta/2$ . The separation between the two frequencies  $\Delta$  and the jumping rate W are chosen to be much smaller than the eigenfrequency. We record the complex amplitude of oscillations u in response to a sinusoidal driving force. When  $\Delta$  is larger than the damping constant  $\Gamma$ , the amplitude spectrum  $|\langle u \rangle|$  consists of two distinct peaks for small  $W(\langle \ldots \rangle$  stands for the time-averaged value). As W increases, the two peaks merge into a single peak, displaying spectral broadening followed by narrowing in a manner analogous to motional narrowing<sup>26,27</sup>. For  $\Delta \sim \max(\Gamma, W)$ , the broadening is small, making it difficult to identify the existence of frequency noise solely from the conventional spectrum of the response to periodic drive. We demonstrate that the deviation of the higher moments of the complex amplitude  $\langle u^n \rangle$  from the powers of the averaged complex amplitude  $\langle u \rangle^n$  unambiguously indicates the presence of frequency noise. The shapes of the spectra of  $|\langle u^2 \rangle / \langle u \rangle^2|$  and  $|\langle u^3 \rangle / \langle u \rangle^3|$  depend strongly on W and  $\Delta$  of the RTFN, in good agreement with theory. Remarkably, this method of studying the characteristics of the frequency noise remains valid even in the presence of strong thermal or detector noise, when conventional schemes fail to reveal the existence of frequency noise. It does not require driving the resonator to large vibrational amplitudes, and thus avoids the problems related to the resonator nonlinearity.

## II. MICROMECHANICAL TORSIONAL RESONATOR AND DETECTION CIR-CUITRY

The torsional resonator in our experiment consists of a highly doped polycrystalline silicon plate with dimensions 200  $\mu$ m × 200  $\mu$ m × 3.5  $\mu$ m, suspended by two torsional rods (36  $\mu$ m × 4  $\mu$ m × 2  $\mu$ m) at the middle of opposite edges [Fig. 1(a)]. Two electrodes are located underneath the plate, one on each side of the torsional rods. The gap between the top plate and the electrodes is created by etching away a 2  $\mu$ m sacrificial silicon oxide layer.

The rotation angle  $\theta$  of the plate is measured by a capacitance bridge<sup>28</sup> that detects the



FIG. 1. (Color online) (a) Scanning electron micrograph of the micromechanical torsional oscillator. (b) Cross-sectional schematic of the device and the measurement circuitry. (c) Typical telegraph noise voltage that is applied to the left electrode. (d) The amplitude spectra of the resonator  $|\langle u \rangle|$ with eigenfrequency shifts  $\xi = \pm \Delta/2$  (right and left peak respectively).  $\Delta = 1.665$  rad s<sup>-1</sup> is constant in time. The dash-dotted curve is an average of the two solid curves.

difference of the capacitance  $C_1$  and  $C_2$  between the top plate and the two bottom electrodes [Fig. 1(b)]. Two 180° out-of-phase ac voltages ( $V_{c1}$  and  $V_{c2}$ ) at frequency  $\omega_{\text{carrier}}$  (typically  $2.5 \times 10^7 \text{ rad s}^{-1} \gg \omega_0$ ) are applied to the two bottom electrodes respectively. As the plate rotates,  $C_1$  increases and  $C_2$  decreases. For small rotations, the amplitude of the ac voltage at  $\omega_{\text{carrier}}$  on the top plate is proportional to  $C_1 - C_2$ , which is in turn proportional to  $\theta$ . A lockin amplifier referenced to  $\omega_{\text{carrier}}$  measures the ac voltage on the top plate, yielding an output that is proportional to  $\theta(t)$ . All measurements are performed at 77 K and  $< 10^{-5}$ torr.

The equation of motion of the top plate is given by:

$$\ddot{\theta} + 2\Gamma\dot{\theta} + [\omega_0 + \xi(t)]^2 \theta = F\cos(\omega_F t) + f_{th}(t).$$
(1)

The term  $F \cos(\omega_F t)$  represents a periodic electrostatic torque generated by a sinusoidal voltage  $V_F$  (amplitude 100  $\mu$ V) on top of a dc voltage (-0.1 V) applied to the electrode on the right.  $\omega_F$  is chosen to be close to the eigenfrequency  $\omega_0 = 134024.383$  rad s<sup>-1</sup> in the absence of frequency noise  $\xi(t)$ . F is kept small so that the oscillations remain linear.  $\Gamma = 0.35$  rad s<sup>-1</sup> is the damping constant and  $f_{th}$  represents the thermal noise. To measure the oscillation amplitude, the output of the first lockin amplifier (proportional to  $\theta(t)$  as described earlier) is fed into a second lockin amplifier that is referenced to  $\omega_F$ . The output of the second lockin amplifier X(t) and Y(t) give the oscillation amplitude in phase and out of phase with the periodic driving torque respectively.

Changes in the resonant frequency  $\xi(t) \ll \omega_0$  are induced by a voltage  $V_{\xi}$  applied to the left electrode, by the spring softening effect associated with the electrostatic force gradient. Figure 1(d) shows the oscillation amplitude as a function of  $\delta \omega = \omega_F - \omega_0$ . The blue and red curves are measured when  $\xi$  remains constant with time, at values of  $\pm \Delta/2$  where  $\Delta = 1.665$ rad s<sup>-1</sup>, corresponding to dc voltages of  $V_1 = 0$  V and  $V_2 = -28$  mV respectively applied to the left electrode.

Next, we replace the constant dc voltages by a voltage signal that consists of telegraph noise switching back and forth between the two voltages  $V_1$  and  $V_2$ , so that the eigenfrequency of the resonator jumps randomly between the two values  $\omega_0 \pm \Delta/2$ . The telegraph voltage signal is generated by a J-K flipflop, triggered by Gaussian noise that is created by amplifying the Johnson noise of a 50  $\Omega$  resistor. Switching of the flipflop occurs when the Gaussian noise exceeds a threshold. The rate of switching W is therefore controlled by the Gaussian noise intensity. For all measurement presented here, W is chosen to be at least 296 times smaller than the eigenfrequency. We checked that the time intervals between switching of the flipflop are random and obey Poisson statistics. To eliminate ringing of the top plate, an RC filter is used to increase the rise time of the voltage steps to  $\tau = 0.011 \text{ ms} (1/\omega_0 < \tau \ll 1/W)$ .

## III. COMPLEX VIBRATION AMPLITUDE AND THE HIGHER MOMENTS IN THE PRESENCE OF TELEGRAPH FREQUENCY NOISE

In the analysis, it is convenient to transform the resonator motion into the rotating frame and introduce the complex vibrational amplitude u = X + iY that is given by:

$$\theta(t) = u \exp(i\omega_F t) + u^* \exp(-i\omega_F t),$$
  
$$\frac{d\theta(t)}{dt} = i\omega_F [u \exp(i\omega_F t) - u^* \exp(-i\omega_F t)].$$
 (2)

In the experiment, X(t) and Y(t) are the oscillation amplitudes that are in phase and out of phase with the periodic driving torque respectively, measured by the second lockin amplifier. The effect of different types of frequency noise on the time averaged  $|\langle u \rangle|$  and the higher moments  $|\langle u^n \rangle|$  (n = 1, 2, ...) was described in detail in Ref. [25]. Here we apply this theory to the telegraph frequency noise used in our experiment.  $|\langle u^n \rangle|$  can be obtained from a vector  $\mathbf{U}(n)$  with two components  $U_i(n)(i=1,2)$ :

$$\mathbf{M}(n)\mathbf{U}(n) = -\frac{inF}{4\omega_F}\mathbf{U}(n-1),\tag{3}$$

where

$$\mathbf{M}(n) = n(\Gamma + i\delta\omega)\mathbf{I} - \frac{in\sigma_z\Delta}{2} + \mathbf{W},$$
$$\mathbf{W} = \frac{1}{2} \begin{pmatrix} W & -W \\ -W & W \end{pmatrix}, \quad \mathbf{U}(0) = \begin{pmatrix} 1 \\ 1 \end{pmatrix}.$$

 $\mathbf{I}, \sigma_z$  are the identity matrix and Pauli matrix respectively. The solution of Eq. (3) is

$$\mathbf{U}(n) = n! \left(\frac{-iF}{4\omega_F}\right)^n \prod_{k=n}^1 \mathbf{M}^{-1}(k) \mathbf{U}(0).$$
(4)

The averaged moments are given by  $\langle u^n \rangle = (1 \ 1) \cdot \mathbf{U}(n)/2.$ 

In the absence of frequency noise,  $|\langle u \rangle|$  is the square root of a Lorentzian function [Fig. 1(d)]. When the resonator is subjected to RTFN, the most intuitive case involves  $W/\Delta \ll 1$ , where either the interval between the two frequencies is large or the switching rate is small. In a simple picture, the resonator settles into one of the two oscillation states with well-defined amplitude and phase between consecutive switching events. One expects that the amplitude spectrum is the weighted summation of two independent amplitude spectra, with the weights being proportional to the occupation probability of the two states (both are 1/2 for the telegraph noise we used). In Fig. 1(d), the dash-dotted curve is the average of the red and blue curves. Since  $\Delta \sim 4.8\Gamma$ , two peaks can be clearly resolved. As  $W/\Delta$  increases, the spectrum of  $|\langle u \rangle|$  evolves according to Eq. (4) in a non-trivial manner.

## IV. MEASURED COMPLEX VIBRATION AMPLITUDE: MERGING OF SPEC-TRAL PEAKS WITH INCREASING SWITCHING RATE

Figure 2(a) shows the measured  $|\langle u \rangle|$  vs driving frequency  $\omega_F$  when the resonator is subjected to RTFN with a fixed  $\Delta$  but different switching rates W. The measurement time for each frequency is chosen to be sufficiently long (involving more than 300 switches) to accurately determine time-averaged values of u. At  $W/\Delta = 0.05$  rad<sup>-1</sup>, two peaks are clearly resolved as expected [see the hollow triangles in Fig. 2(a)]. However, as W increases,



FIG. 2. (Color online) (a) Measured spectra of the time-averaged complex amplitude  $|\langle u \rangle|$  of the resonator under RTFN with different  $W/\Delta$ .  $\Delta$  is kept constant at 1.665 rad s<sup>-1</sup>. For clarity, successive curves are shifted by 10  $\mu$ rad. (The symbols  $\triangleright$ , \*,  $\circ$ ,  $\blacksquare$ ,  $\diamond$ , and • correspond to  $W/\Delta = 0.05$ , 0.15, 0.45, 2.36, 43.26 rad<sup>-1</sup> and no frequency noise applied respectively.) (b) The corresponding ratios  $|\langle u^2 \rangle / \langle u \rangle^2|$ , and (d)  $|\langle u^3 \rangle / \langle u \rangle^3|$ . (c) The expanded views of the ratios  $|\langle u^2 \rangle / \langle u \rangle^2|$ , and (e)  $|\langle u^3 \rangle / \langle u \rangle^3|$  around 1. In all panels, the lines are the calculated spectra.

the simple picture described above is no longer valid. For  $W/\Delta = 2.36 \text{ rad}^{-1}$ , the two peaks merge into a single peak with width smaller than  $\Delta$  (solid squares). As predicted in Refs. [24] and [25], the partial spectra are strongly coupled and interference occurs. An intuitive understanding is that in order to resolve two peaks separated by  $\Delta$  by sweeping the driving frequency, one needs to measure for a duration longer than  $1/\Delta$ . When  $W \gg \Delta, \Gamma$ , the resident time in one state is not long enough for the resonator to discriminate between the two states and the spectrum becomes a single peak centered at  $\omega_0$  whose width is broadened from the linewidth  $\Gamma$  in the absence of frequency noise. As a result, the frequency noise leads to diffusion of the oscillator phase. As  $W/\Delta$  is further increased to 43.26 rad<sup>-1</sup>, the single peak continues to narrow [hollow diamonds in Fig. 2(a)]. In this limit, the resonator can no longer respond to the rapid changes in the resonant frequency. Vibrations occur as if the resonant frequency is held at a constant, time-averaged value. The scenario is analogous to motional narrowing in nuclear magnetic resonance where atoms undergo diffusion in liquids $^{26,27}$ . When the spectral modulation amplitude is much smaller than the inverse of the modulation correlation time, the atoms experience an averaged magnetic field and the resonance linewidth is smaller compared to the case when the atoms are stationary. In Fig. 2(a), the lines are the calculated amplitude spectrum based on Eqs. (3) and (4) with no fitting parameters. There is good agreement between measurement and theory for all values of  $W/\Delta$ .

## V. MEASURED HIGHER MOMENTS OF THE COMPLEX VIBRATION AM-PLITUDE

Next, we study the effect of the RTFN on the averaged second and third moments. Figures 2(b) and 2(d) plot the ratios  $|\langle u^2 \rangle / \langle u \rangle^2|$  and  $|\langle u^3 \rangle / \langle u \rangle^3|$  respectively, corresponding to the same parameter values in Fig. 2(a). Figures 2(c) and 2(e) zoom into the regions where the ratios are close to 1. As shown by the solid circles, in the absence of external frequency noise, both ratios are equal to 1 within experimental uncertainty. In the presence of RTFN, they deviate from 1. The shape of the spectra is determined by  $\Delta$  and W. At  $W/\Delta = 0.05 \text{ rad}^{-1}$ , the spectrum of  $|\langle u^2 \rangle / \langle u \rangle^2|$  displays a single peak centered at  $\omega_0$  while the entire curve is above 1 (hollow triangles). As W increases, the spectrum dips below 1 with two maxima on its sides. When W increases beyond  $\Delta$  and  $\Gamma$ , the ratio approaches 1. The spectra of  $|\langle u^3 \rangle / \langle u \rangle^3|$  evolve in a qualitatively similar fashion. There is good agreement with theory (solid lines) in Figs. 2(b-e).

#### VI. EFFECTS OF THERMAL/DETECTOR NOISE AND MEASUREMENT TIME

For several parameter values in Fig. 2, the spectrum of  $|\langle u \rangle|$  exhibits a single peak in the presence of RTFN while  $|\langle u^2 \rangle / \langle u \rangle^2|$  and  $|\langle u^3 \rangle / \langle u \rangle^3|$  deviates significantly from 1. In such cases, the analysis of the high moments of u allows unambiguous identification the existence of frequency noise even when the thermal or detector noise is strong. Figure 3(a) plots the averaged amplitude spectrum of the resonator for relatively weak frequency noise ( $\Delta = 0.5\Gamma$ and  $W/\Delta = 1.76 \text{ rad}^{-1}$ ). The spectrum is slightly broadened but is still well-fitted by the square root of a Lorentzian, yielding a width that is 4.6% larger than the intrinsic damping constant  $\Gamma$ . By examining the width of the amplitude spectrum alone, it is not possible to separate the effects of frequency noise from damping. To reveal the existence of frequency noise, the conventional method involves examining the complex amplitude distribution in the X-Y phase space. Figure 3(b) shows three different distributions when  $\omega_F$  is set to be



FIG. 3. (Color online) (a) Measured amplitude spectrum under weak frequency noise ( $\Delta = 0.5\Gamma$ ,  $W/\Delta = 1.76 \text{ rad}^{-1}$ ). The solid line is a fit of the square root of a Lorentzian, yielding a width that is 4.6% larger than  $\Gamma$ . (b) The distribution of the measured complex amplitudes in the X-Y phase diagram. With the external frequency noise removed, thermal motion of the resonator leads to isotropic distributions centered at the origin (no periodic drive, red) and at the bottom (periodic drive at  $\omega_F = \omega_0$ , orange). The dashed line represents the calculated X and Y when the driving frequency is swept through  $\omega_0$ . When the resonator is subjected to frequency noise as in (a), the distribution (blue) elongates along the dashed line. (c) The bandwidth of the lock-in is increased by about 1,000 so that detector noise makes it more difficult to identify frequency fluctuations.

equal to  $\omega_0$ . For the red points, the driving amplitude F is turned to zero and external frequency noise is absent. Readings of the lock-in amplifier are recorded every 33 ms with a time constant of 300 ms. The finite width of the distribution is associated with the thermal mechanical fluctuations (~ 0.2  $\mu$ rad) of our resonator at 77 K. When F is turned back on, the distribution is displaced along the vertical axis so that it is centered at a negative Yvalue, because the average oscillation phase lags behind the drive by  $\pi/2$  at resonance. Both distributions are circular in shape due to the phase-random nature of thermal noise. When the RTFN is introduced, the distribution becomes elongated along the X direction. Such anisotropic broadening is distinct from that associated with thermal noise. In general, it serves as a signature for the presence of frequency noise.

The aforementioned method of isolating the contributions of frequency noise becomes inapplicable when the thermal noise of the resonator or detector noise in the electronic circuit is large. In Fig. 3(c), we repeat the measurement with the detection bandwidth increased by about a factor of 1,000 while the external frequency noise remains unchanged. The phase-random detector noise leads to additional isotropic broadening in the X-Y phase space, beyond that induced by thermal noise. For the distribution in Fig.3(c) in the presence of frequency noise and periodic driving, the elongation in the distribution due to frequency noise is largely masked by the detector noise. Figure 3(c) shows that it becomes significantly more difficult to identify frequency noise by inspecting the distribution in the X-Y phase space when either the thermal noise or the detector noise is large.



FIG. 4. Spectra of the ratios (a)  $|\langle u^2 \rangle / \langle u \rangle^2|$ , and (b)  $|\langle u^3 \rangle / \langle u \rangle^3|$  for the same experimental conditions and under the same frequency noise as in Fig. 3. The open and solid circles correspond to lockin time constants of 300 ms and 300  $\mu$ s respectively. They correspond to panels (b) and (c) of Fig. 3 respectively. The solid line is the theoretical prediction using Eq. (4). The dashed line shows the calculated values when the telegraph frequency noise is replaced by white Gaussian frequency noise with the intensity  $D = \Delta/2\sqrt{2}$ .

Figure 4(a) plots, for the same experimental conditions and under the same frequency noise as in Fig. 3, the spectra of the ratio  $|\langle u^2 \rangle / \langle u \rangle^2|$ . The solid circles and hollow circles in Fig. 4(a) correspond to the measured values for large [Fig. 3(c)] and small [Fig. 3(b)] detector noise respectively. To make the statistical error comparable, the time of averaging for the solid circles is chosen to be 4 times longer than the hollow circles. Both the solid circles and the hollow circles are in good agreement with the prediction of Eq. (4), shown as the solid line. Provided that the resonator and the detection circuit remain in the linear regime, the predicted values are independent of the presence of thermal and detector noise because both are phase random relative to the periodic driving. Figure 4(b) shows a similar plot for the ratio  $|\langle u^3 \rangle / \langle u \rangle^3|$ . Our measurements support the notion that the deviations of the higher moment ratios  $|\langle u^n \rangle / \langle u \rangle^n|$  from one remain a robust indicator of the presence of frequency noise, even when the thermal noise and/or detector noise is strong.

For all the data presented in this paper, the measurement time is chosen to be much longer than the inverse switching rate, so that the time-averaged values of u and the higher moments are associated with many frequency jumps to reduce the measurement uncertainty. In this limit, the predicted lineshapes of the spectra of  $|\langle u^2 \rangle / \langle u \rangle^2|$  and  $|\langle u^3 \rangle / \langle u \rangle^3|$  are independent of the measurement time. In experiments where thermal or detector noise are present, the measurement time may need to be further increased for accurate measurement of these ratios.

## VII. COMPARISON OF THE EFFECTS OF TELEGRAPH NOISE AND GAUS-SIAN NOISE

The analysis of the spectra of the higher moments of the complex amplitude is not only limited to telegraph frequency noise. In Figs. 4(a) and 4(b), the dashed line shows the predicted ratios of  $|\langle u^2 \rangle / \langle u \rangle^2|$  and  $|\langle u^3 \rangle / \langle u \rangle^3|$  when the frequency noise  $\xi(t)$  follows a white Gaussian distribution, instead of jumping randomly between two levels<sup>25</sup>. Here, the intensity D of the Gaussian frequency noise is chosen to be  $\Delta/2\sqrt{2}$ , where  $\langle \xi(t)\xi(t') \rangle = 2D\delta(t-t')$ , so that the telegraph noise and Gaussian noise have the same variance. In both Figs. 4(a) and 4(b), the ratios for Gaussian noise deviate from one, but in a manner different from telegraph noise. They remain smaller than one over the entire range of  $\delta\omega$ , attaining a minimum at  $\delta\omega = 0$ . In contrast, for the measurements with telegraph noise [Figs. 2(b), 2(d), 4(a) and 4(b)], there exists a certain range of  $\delta\omega$  where the ratios exceed 1. It is possible that in addition to determining the existence of frequency noise, the analysis of the higher moments of u might prove useful in the study of noise characteristics. Based on the current study, we cannot conclude if the aforementioned differences in the spectra are specific to the ranges of parameters in our experiment or universal features of telegraph and Gaussian noise. This is an important topic that warrants further theoretical analysis.

#### VIII. CONCLUSIONS

We have demonstrated that the presence of RTFN can be identified by the moments of the complex amplitude u of an underdamped driven micromechanical oscillator. When either the interval between the two frequencies is large or the switching rate is small, the time-averaged vibration amplitude spectrum exhibits two peaks. They merge with increasing rate of frequency switching and the spectrum displays an analog of motional narrowing. We also show that the moments of the complex amplitude depend strongly on the frequency noise characteristics. Such analysis of the higher moments of u are particularly useful in revealing the existence of frequency noise when thermal or detector noise is strong. Moreover, this

method is directly applicable to other linear resonators with high quality factors, such as Josephson junctions<sup>3,29</sup> and optical cavities.

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## X. APPENDIX: INDEPENDENCE OF THE HIGHER MOMENTS OF COMPLEX VIBRATIONAL AMPLITUDE ON THERMAL/DETECTOR NOISE

Thermal motion of the resonator and/or detector noise in the measurement circuitry often prevents one from identifying the existence of frequency noise using conventional methods such as measurement of the ringdown of oscillations. In the main text, we demonstrated experimentally that by measuring the ratios of the higher moments  $|\langle u^2 \rangle / \langle u \rangle^2|$  or  $|\langle u^3 \rangle / \langle u \rangle^3|$ , it is possible to detect the existence of frequency noise even when detector noise is strong, provided that sufficient averaging is performed. Here, we provide an explanation to why such an analysis is immune to thermal/detector noise.

In the experimental measurement of u, the recorded signal can be written as:

$$u = (X + \Delta X) + i(Y + \Delta Y).$$
(5)

 $\Delta X$  and  $\Delta Y$  originates from thermal or detector noise. They have zero mean and are uncorrelated with each other and also with X and Y if the resonator and detection circuit both remain linear. Provided that sufficient averaging is done,  $|\langle u \rangle^n|$  equals  $|\langle X + iY \rangle^n|$ . The numerator of the ratio considered in the main text,  $|\langle u^n \rangle|$ , contains cross terms between  $\Delta X$ ,  $\Delta Y$ , X and Y. For example, consider the case of n = 2 measured in our experiment:

$$\langle [(X + \Delta X) + i(Y + \Delta Y)]^2 \rangle = \langle X^2 \rangle - \langle Y^2 \rangle + 2(\langle X \rangle \langle \Delta X \rangle - \langle Y \rangle \langle \Delta Y \rangle) + (\langle (\Delta X)^2 \rangle - \langle (\Delta Y)^2 \rangle) + i(\langle X \rangle \langle Y \rangle + \langle \Delta X \rangle \langle Y \rangle + \langle \Delta Y \rangle \langle X \rangle + \langle \Delta X \rangle \langle \Delta Y \rangle)$$
(6)

All the terms with  $\langle \Delta X \rangle$  or  $\langle \Delta Y \rangle$  average to zero. Because  $\Delta X$  and  $\Delta Y$  due to thermal/detector noise follow the same distribution,  $\langle (\Delta X)^2 \rangle = \langle (\Delta Y)^2 \rangle$ . Therefore  $|\langle u^2 \rangle|$  is identical to the case when thermal/detector noise are absent. In general, phase noise is incorporated into the higher moments while additive noise such as thermal or detector noise are not. As a result, with sufficient averaging the higher moments can be used to reveal the existence of frequency noise.

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- <sup>1</sup> M. Gitterman, *The Noisy Oscillator* (World Scientific, 2005).
- <sup>2</sup> J. Clarke and F. K. Wilhelm, Nature, **453**, 1031 (2008).
- <sup>3</sup> J. Li, M. Silveri, K. Kumar, J.-M. Pirkkalainen, A. Vepsäläinen, W. Chien, J. Tuorila, M. Sillanpää, P. Hakonen, E. Thuneberg, *et al.*, Nat. Commun., 4, 1420 (2013).
- <sup>4</sup> A. N. Cleland and M. L. Roukes, J. Appl. Phys., **92**, 2758 (2002).
- <sup>5</sup> T. J. Kippenberg and K. J. Vahala, Science, **321**, 1172 (2008), ISSN 1095-9203.
- <sup>6</sup> T. Faust, J. Rieger, M. J. Seitner, J. P. Kotthaus, and E. M. Weig, Nat. Phys., 9, 485 (2013).
- <sup>7</sup> H. Okamoto, A. Gourgout, C.-Y. Chang, K. Onomitsu, I. Mahboob, E. Y. Chang, and H. Yamaguchi, Nat. Phys., 9, 480 (2013).
- <sup>8</sup> F. J. Giessibl, Rev. Mod. Phys., **75**, 949 (2003).
- <sup>9</sup> D. B. Sullivan, D. W. Allan, D. A. Howe, and E. L. Walls, *Characterization of Clocks and Oscillators* (NIST Tech. Note 1337, 1990).
- <sup>10</sup> E. Rubiola and V. Giordano, IEEE T ULTRASON FERR, **54**, 15 (2007).
- <sup>11</sup> D. Rugar, R. Budakian, H. J. Mamin, and B. W. Chui, Nature, **430**, 329 (2004).
- <sup>12</sup> M. D. LaHaye, J. Suh, P. M. Echternach, K. C. Schwab, and M. L. Roukes, Nature, **459**, 960 (2009).
- <sup>13</sup> K. Jensen, K. Kim, and A. Zettl, Nat. Nanotech., **3**, 533 (2008).
- <sup>14</sup> Z. Wang, J. Wei, P. Morse, J. G. Dash, O. E. Vilches, and D. H. Cobden, Science, **327**, 552 (2010).
- <sup>15</sup> M. S. Hanay, S. Kelber, a. K. Naik, D. Chi, S. Hentz, E. C. Bullard, E. Colinet, L. Duraffourg, and M. L. Roukes, Nat. Nanotech., 7, 602 (2012).
- <sup>16</sup> Y. T. Yang, C. Callegari, X. L. Feng, and M. L. Roukes, Nano letters, **11**, 1753 (2011).
- <sup>17</sup> K. L. Ekinci, X. M. H. Huang, and M. L. Roukes, Appl. Phys. Lett., **84**, 4469 (2004).
- <sup>18</sup> A. A. Clerk, F. Marquardt, and J. G. E. Harris, Phys. Rev. Lett., **104**, 213603 (2010).

- <sup>19</sup> J. Gao, J. Zmuidzinas, B. a. Mazin, H. G. LeDuc, and P. K. Day, Appl. Phys. Lett., **90**, 102507 (2007).
- <sup>20</sup> K. Y. Fong, W. H. P. Pernice, and H. X. Tang, Phys. Rev. B, **85**, 161410 (2012).
- <sup>21</sup> V. Sazonova, Y. Yaish, H. Ustünel, D. Roundy, T. a. Arias, and P. L. McEuen, Nature, 431, 284 (2004).
- J. S. Bunch, A. M. van der Zant, S. S. Verbridge, I. L. Frank, D. M. Tanenbaum, J. M. Parpia,
  H. G. Craighead, and P. L. McEuen, Science, **315**, 490 (2007).
- <sup>23</sup> A. Eichler, J. Moser, J. Chaste, M. Zdrojek, I. Wilson-Rae, and A. Bachtold, Nat. Nanotech.,
  6, 339 (2011).
- <sup>24</sup> M. I. Dykman, M. Khasin, J. Portman, and S. W. Shaw, Phys. Rev. Lett., **105**, 230601 (2010).
- <sup>25</sup> Z. A. Maizelis, M. L. Roukes, and M. I. Dykman, Phys. Rev. B, 84, 144301 (2011).
- <sup>26</sup> P. W. Anderson and P. R. Weiss, Rev. Mod. Phys., **25**, 269 (1953).
- <sup>27</sup> P. W. Anderson, J. Phys. Soc. Jpn., **9**, 316 (1954).
- <sup>28</sup> H. B. Chan, V. A. Aksyuk, R. N. Kleiman, D. J. Bishop, and F. Capasso, Phys. Rev. Lett., 87, 211801 (2001).
- <sup>29</sup> G. J. Grabovskij, T. Peichl, J. Lisenfeld, G. Weiss, and A. V. Ustinov, Science, **338**, 232 (2012).